


<b>Search Notes</b>  	<b>Application/Control No.</b>  10564745	<b>Applicant(s)/Patent Under Reexamination</b>  TAKAYAMA ET AL.
	<b>Examiner</b>  MICHAEL SZPERKA	<b>Art Unit</b>  1644

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
inventor search in eDAN: Takayama, Hiroshi; Shirakawa, Kamon; Yamakawa, Toru; kawahara, Tetsushi	6/4/08	MS
USPAT USPGPUB EPO JPO DERWENT (EAST) see search printouts	6/4/08	MS
MEDLINE AGRICOLA BIOSIS CAPLUS EMBASE SCISEARCH (STN) see search printouts	6/4/08	MS
STIC sequence search, see SCORE	6/4/08	MS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner